

Test Laboratory: BTL

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	280.0 x 190.0 x 30.0		Tablet

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	Edge 3, 0.00	ISM 2.4 GHz Band	Bluetooth, 10038-CAA	2480.000, 78	7.77	1.88	40.7

Hardware Setup

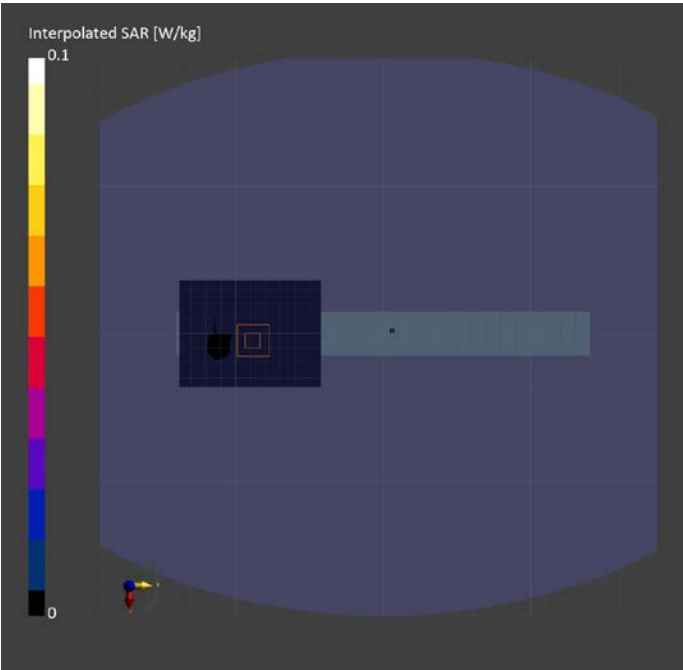
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2273	h2450-260407 , 2026-04-07	EX3DV4 - SN7678, 2025-08-21	DAE4 Sn1764, 2025-04-22

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	72.0 x 96.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	12.0 x 12.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-04-07	2026-04-07
psSAR1g [W/kg]	0.006	0.01
psSAR10g [W/kg]	0.002	0.001
Power Drift [dB]		0.09
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		73.4
Dist 3dB Peak [mm]		4.9



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Flat, Head Simulating Liquid	Edge 3, 0.00	ISM 2.4 GHz Band	Bluetooth, 10670-AAA	2480.000, 78	7.77	1.88	40.7

Hardware Setup

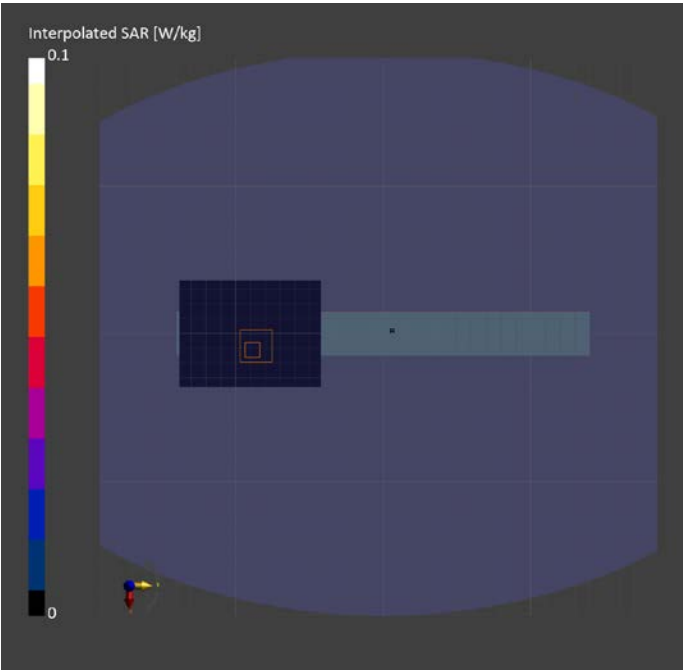
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2273	h2450-260407 , 2026-04-07	EX3DV4 - SN7678, 2025-08-21	DAE4 Sn1764, 2025-04-22

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	72.0 x 96.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	12.0 x 12.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.2
MAIA	Y	Y
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-04-07	2026-04-07
psSAR1g [W/kg]	0.002	0.004
psSAR10g [W/kg]	0	0
Power Drift [dB]		0.12
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		70.6
Dist 3dB Peak [mm]		4.1



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Flat, Head Simulating Liquid	Edge 1, 0.00	WLAN 2.4GHz	WLAN, 10012-CAB	2412.000, 1	7.77	1.81	40.3

Hardware Setup

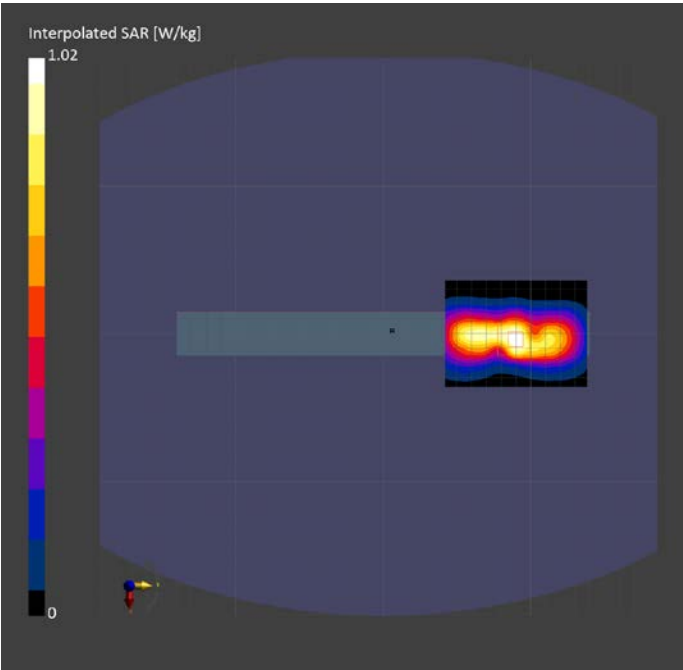
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2273	h2.4G-260410 , 2026-04-10	EX3DV4 - SN7678, 2025-08-21	DAE4 Sn1764, 2025-04-22

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	72.0 x 96.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	12.0 x 12.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-04-10	2026-04-10
psSAR1g [W/kg]	0.821	1.10
psSAR10g [W/kg]	0.425	0.476
Power Drift [dB]		-0.06
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		76.2
Dist 3dB Peak [mm]		7.0



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Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	Edge 3, 0.00	WLAN 2.4GHz	WLAN, 10012-CAB	2442.000, 7	7.77	1.85	40.7

Hardware Setup

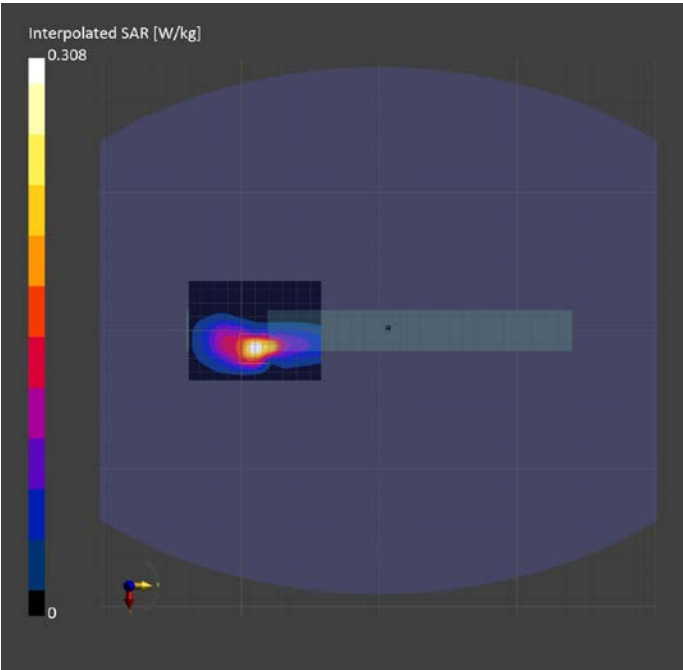
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2273	h2450-260407 , 2026-04-07	EX3DV4 - SN7678, 2025-08-21	DAE4 Sn1764, 2025-04-22

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	72.0 x 96.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	12.0 x 12.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-04-07	2026-04-07
psSAR1g [W/kg]	0.223	0.293
psSAR10g [W/kg]	0.098	0.113
Power Drift [dB]		-0.12
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		77.3
Dist 3dB Peak [mm]		5.5



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Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	Edge 1, 0.00	WLAN 5GHz	WLAN, 10544-AAD	5210.000, 42	6.1	4.55	35.9

Hardware Setup

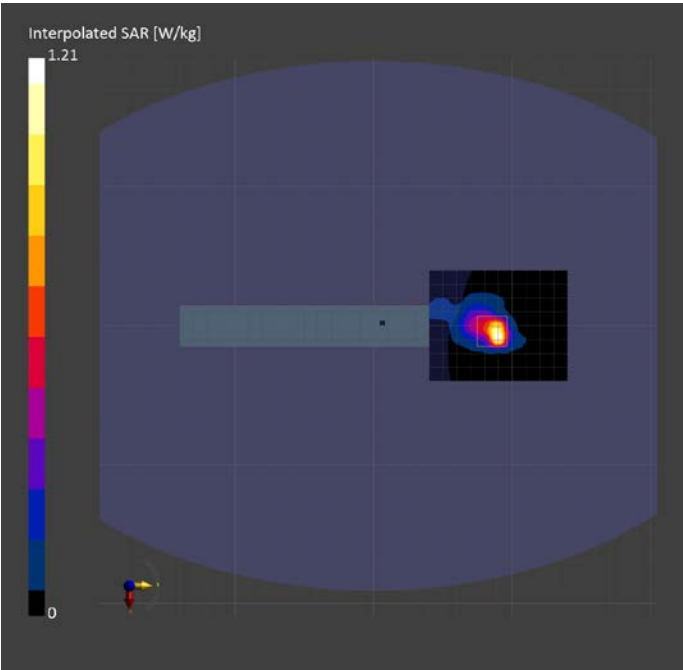
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2273	h5G-260409 , 2026-04-09	EX3DV4 - SN7678, 2025-08-21	DAE4 Sn1764, 2025-04-22

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	80.0 x 90.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-04-09	2026-04-09
psSAR1g [W/kg]	0.797	1.02
psSAR10g [W/kg]	0.250	0.263
Power Drift [dB]		-0.07
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		61.6
Dist 3dB Peak [mm]		6.1



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Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	Edge 3, 0.00	U-NII-1, U-NII-2A	WLAN, 10062-CAE	5240.000, 48	6.1	4.58	35.9

Hardware Setup

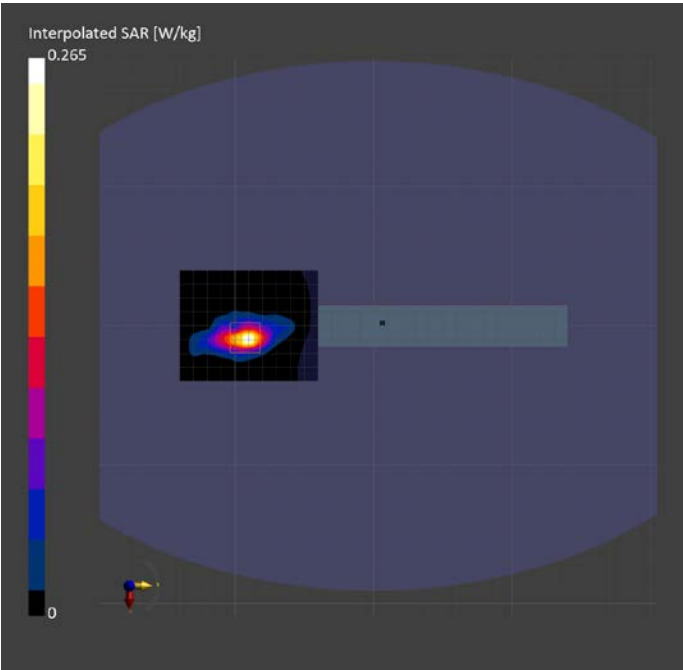
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2273	h5G-260409 , 2026-04-09	EX3DV4 - SN7678, 2025-08-21	DAE4 Sn1764, 2025-04-22

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	80.0 x 90.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-04-09	2026-04-09
psSAR1g [W/kg]	0.169	0.183
psSAR10g [W/kg]	0.054	0.050
Power Drift [dB]		0.03
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		59.1
Dist 3dB Peak [mm]		6.5



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Flat, Head Simulating Liquid	Edge 1, 0.00	WLAN 5GHz	WLAN, 10544-AAD	5775.000, 155	5.42	5.19	34.9

Hardware Setup

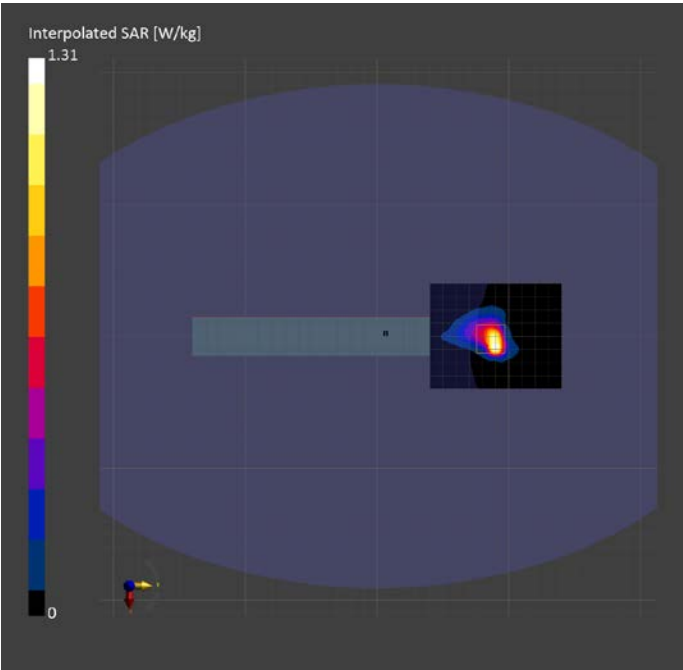
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2273	h5G-260409 , 2026-04-09	EX3DV4 - SN7678, 2025-08-21	DAE4 Sn1764, 2025-04-22

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	80.0 x 90.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-04-09	2026-04-09
psSAR1g [W/kg]	0.863	1.11
psSAR10g [W/kg]	0.265	0.285
Power Drift [dB]		0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		55.8
Dist 3dB Peak [mm]		5.7



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Flat, Head Simulating Liquid	Edge 3, 0.00	WLAN 5GHz	WLAN, 10599-AAD	5795.000, 159	5.42	5.39	34.9

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2273	h5G-260410 , 2026-04-10	EX3DV4 - SN7678, 2025-08-21	DAE4 Sn1764, 2025-04-22

Scan Setup

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Grid Extents [mm]	80.0 x 90.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	N/A
Surface Detection	All points	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-04-10	2026-04-10
psSAR1g [W/kg]	0.301	0.342
psSAR10g [W/kg]	0.109	0.104
Power Drift [dB]		-0.09
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		53.8
Dist 3dB Peak [mm]		7.3

